### June/2004

## MITSUBISHI SEMICONDUCTOR <GaAs FET> MGF4953A/MGF4954A

SUPER LOW NOISE InGaAs HEMT (Leadless Ceramic Package)

| DESCRIPTION   |   |
|---|---|
| The MGF4953A/MGF4954A super-low noise HEMT (High              |   |
| Electron Mobility Transistor) is designed for use in C to K I |   |
| amplifiers.   |   |
| The lead-less ceramic package assures minimum paras           | tic losses.   |
|   |   |
| FEATURES  |   |
| Low noise figure @ f=12GHz                                    |   |
| MGF4953A : NFmin. = 0.40dB (Typ.)                             |   |
| MGF4954A : NFmin. = 0.60dB (Typ.)                             | Fig.1   |
|   |   |
| High associated gain @ f=12GHz                                |   |
| Gs = 13.5dB (Typ.)  |   |
| APPLICATION   | MITSUBISHI Proprietary  |
| C to K band low noise amplifiers                              | Not to be reproduced or disclosed<br>without permission by Mitsubishi Electric                        |
| QUALITY GRADE   |   |
| GG  |   |
|   |   |
| RECOMMENDED BIAS CONDITIONS                                   |   |
| $V_{DS}=2V$ , $I_{D}=10mA$                                    |   |
|   |   |
| ORDERING INFORMATION  |   |
| Tape & reel 3000pcs./reel                                     |   |
|   | Koon Sofaty first in your sireuit designal  |
|   | Keep Safety first in your circuit designs!<br>Mitsubishi Electric Corporation puts the maximum        |
|   | effort into making semiconductor products better  |
|   | and more reliable, but there is always the  |
|   | possibility that trouble may occur with them.   |
| ABSOLUTE MAXIMUM RATINGS (Ta=25°C)                            | Trouble with semiconductors may lead to personal<br>injury, fire or property damage. Remember to give |
|   | ,, ,  |

| Symbol           | Parameter               | Ratings     | Unit |
|------------------|-------------------------|-------------|------|
| V <sub>GDO</sub> | Gate to drain voltage   | -4          | V    |
| V <sub>GSO</sub> | Gate to source voltage  | -4          | V    |
| I <sub>D</sub>   | Drain current           | 60          | mA   |
| PT               | Total power dissipation | 50          | mW   |
| T <sub>ch</sub>  | Channel temperature     | 125         | °C   |
| T <sub>stg</sub> | Storage temperature     | -65 to +125 | °C   |

due consideration to safety when making your circuit designs , with appropriate measure such as (I) placement of substitutive , auxiliary circuits , (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

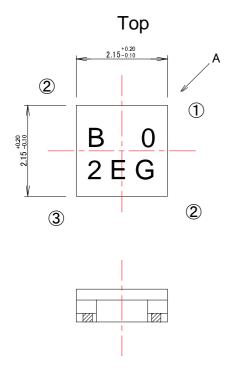
#### ELECTRICAL CHARACTERISTICS (Ta=25°C)

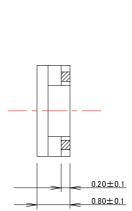
| Synbol                | Parameter                       | Test conditions                       |  | Limits |      |      | Unit |
|-----------------------|---------------------------------|---------------------------------------|--|--------|------|------|------|
|                       |                                 |                                       |  |        | TYP. | MAX  |      |
| V <sub>(BR)</sub> GDO | Gate to drain breakdown voltage | I <sub>G</sub> =-10μΑ                 |  | -3     |      |      | V    |
| I <sub>GSS</sub>      | Gate to source leakage current  | V <sub>GS</sub> =-2V,V <sub>DS</sub>  | 3=0V                                     |        |      | 50   | μΑ   |
| IDSS                  | Saturated drain current         | V <sub>GS</sub> =0V,V <sub>DS</sub> : | =2V                                      | 15     |      | 60   | mA   |
| V <sub>GS(off)</sub>  | Gate to source cut-off voltage  | V <sub>DS</sub> =2V,I <sub>D</sub> =5 | 00μΑ                                     | -0.1   |      | -1.5 | V    |
| gm                    | Transconductance                | V <sub>DS</sub> =2V,I <sub>D</sub> =1 | V <sub>DS</sub> =2V,I <sub>D</sub> =10mA |        | 70   |      | mS   |
| Gs                    | Associated gain                 | V <sub>DS</sub> =2V,                  | V <sub>DS</sub> =2V,                     |        | 13.5 |      | dB   |
| NFmin.                | Minimum noise figure            | I <sub>D</sub> =10mA                  | MGF4953A                                 |        | 0.40 | 0.50 | dB   |
|                       |                                 | f=12GHz                               | MGF4954A                                 |        | 0.60 | 0.80 | dB   |

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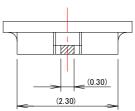
SUPER LOW NOISE InGaAs HEMT (Leadless Ceramic Package)

Fig.1



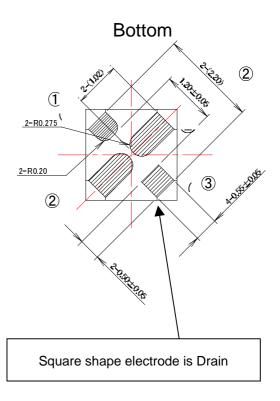


Side



from "A" side view

Unit : mm





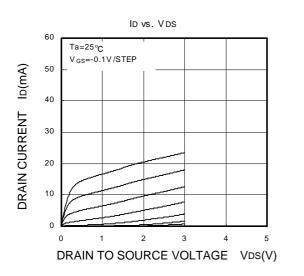
# MITSUBISHI

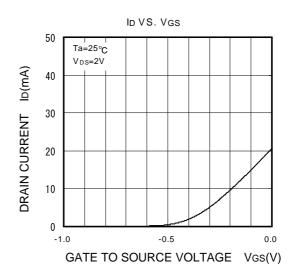
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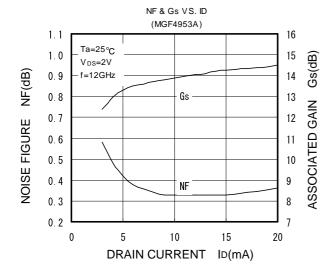
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### SUPER LOW NOISE InGaAs HEMT (Leadless Ceramic Package)

# **S PARAMETERS**

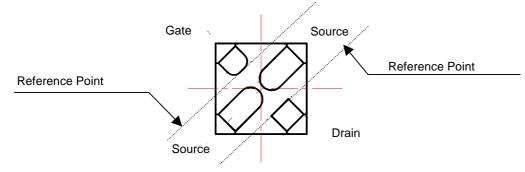
#### (Ta=25°C,VDS=2V,ID=10mA)

| Freq  | S     | 11     | S     | 21     | S12   |        | 2 \$22 |        |
|-------|-------|--------|-------|--------|-------|--------|--------|--------|
| (GHz) | (mag) | (ang)  | (mag) | (ang)  | (mag) | (ang)  | (mag)  | (ang)  |
| 1     | 0.911 | -12.7  | 4.924 | 168.1  | 0.008 | 70.3   | 0.709  | -10.7  |
| 2     | 0.894 | -29.2  | 4.806 | 155.3  | 0.031 | 68.8   | 0.691  | -22.7  |
| 3     | 0.875 | -40.7  | 4.796 | 142.7  | 0.043 | 62.2   | 0.682  | -30.1  |
| 4     | 0.858 | -53.9  | 4.672 | 131.6  | 0.061 | 49.4   | 0.652  | -41.7  |
| 5     | 0.830 | -66.5  | 4.524 | 121.2  | 0.066 | 42.9   | 0.639  | -49.6  |
| 6     | 0.797 | -77.7  | 4.308 | 109.5  | 0.073 | 33.5   | 0.631  | -58.5  |
| 7     | 0.770 | -87.0  | 4.114 | 101.1  | 0.080 | 26.2   | 0.628  | -64.4  |
| 8     | 0.751 | -94.2  | 3.984 | 90.8   | 0.089 | 22.1   | 0.625  | -71.0  |
| 9     | 0.727 | -103.0 | 3.886 | 81.4   | 0.090 | 17.4   | 0.624  | -76.1  |
| 10    | 0.713 | -110.8 | 3.881 | 75.0   | 0.101 | 9.2    | 0.628  | -80.4  |
| 11    | 0.686 | -119.9 | 3.886 | 66.0   | 0.110 | 2.2    | 0.612  | -87.5  |
| 12    | 0.636 | -132.8 | 3.937 | 54.7   | 0.120 | -4.6   | 0.581  | -94.3  |
| 13    | 0.590 | -146.6 | 4.078 | 45.0   | 0.127 | -13.0  | 0.540  | -101.0 |
| 14    | 0.538 | -165.8 | 4.163 | 31.5   | 0.136 | -25.2  | 0.485  | -112.5 |
| 15    | 0.507 | 170.2  | 4.239 | 18.9   | 0.144 | -35.8  | 0.396  | -122.4 |
| 16    | 0.506 | 140.8  | 4.238 | 4.5    | 0.151 | -48.2  | 0.283  | -137.3 |
| 17    | 0.552 | 110.4  | 4.067 | -10.5  | 0.151 | -62.0  | 0.159  | -162.3 |
| 18    | 0.625 | 86.0   | 3.791 | -26.5  | 0.145 | -74.0  | 0.076  | 120.8  |
| 19    | 0.696 | 65.9   | 3.428 | -40.5  | 0.137 | -85.8  | 0.164  | 54.1   |
| 20    | 0.745 | 50.8   | 3.045 | -54.3  | 0.118 | -97.6  | 0.271  | 31.6   |
| 21    | 0.791 | 38.2   | 2.677 | -66.5  | 0.109 | -106.8 | 0.375  | 20.9   |
| 22    | 0.794 | 28.2   | 2.281 | -76.2  | 0.102 | -114.0 | 0.455  | 14.3   |
| 23    | 0.776 | 18.4   | 1.984 | -84.5  | 0.091 | -118.9 | 0.539  | 8.5    |
| 24    | 0.802 | 11.0   | 1.828 | -93.8  | 0.078 | -127.7 | 0.607  | 5.7    |
| 25    | 0.796 | 2.9    | 1.626 | -102.1 | 0.071 | -130.2 | 0.675  | 2.1    |
| 26    | 0.799 | -8.5   | 1.424 | -114.5 | 0.064 | -138.3 | 0.730  | 0.9    |

# NOISE PARAMETERS (Ta=25°C,VDS=2V,ID=10mA)

| f     | Gamn  | na-opt | Rn    | NFmin. | Gs   |
|-------|-------|--------|-------|--------|------|
| (GHz) | Magn. | Angle  | (ohm) | (dB)   | (dB) |
| 4     | 0.64  | 52.7   | 0.27  | 0.22   | 18.3 |
| 8     | 0.61  | 103.5  | 0.15  | 0.28   | 15.9 |
| 12    | 0.55  | 146.4  | 0.06  | 0.35   | 13.5 |
| 14    | 0.51  | 161.9  | 0.04  | 0.39   | 12.5 |
| 18    | 0.41  | 175.3  | 0.03  | 0.48   | 11.0 |
| 20    | 0.35  | -177.3 | 0.05  | 0.55   | 10.5 |

Note) Rn is normalized by 50-ohm



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